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Nizkonapetostne stikalne in krmilne naprave - 2. del: Odklopniki

Low-voltage switchgear and controlgear - Part 2: Circuit-breakers

Niederspannungsschaltgeräte - Teil 2: Leistungsschalter

Appareillage à basse tension - Partie 2: Disjoncteurs

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OF INTEREST TO THE FOLLOWING COMMITTEES: SC 23E	PROPOSED HORIZONTAL STANDARD: <input type="checkbox"/> Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.
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TITLE:

Low-voltage switchgear and controlgear - Part 2: Circuit-breakers

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SC121A Officers support circulation of CDV for project IEC 60947-2 ED6.

Secretary Note: NC experts are kindly requested to refer their comments to line numbers.

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